## Application No. Applicant(s) 09/842,161 IWAI ET AL. Intervi w Summary Examiner Art Unit Gina C. Yu 1617 All participants (applicant, applicant's representative, PTO personnel): 10 (1) Gina C. Yu. (3) Tom Cunningham. (2) Sreeni Padnamahban. (4)\_\_\_\_\_ Date of Interview: March 27, 2003 . Type: a) Telephonic b) Video Conference c) Personal [copy given to: 1) applicant 2) applicant's representative] Exhibit shown or demonstration conducted: d) Yes e) 🛣 No. If Yes, brief description: \_ Claim(s) discussed: \_ All pending Identification of prior art discussed: Yu, Ansel Agreement with respect to the claims f) was reached. g) was not reached. h) N/A. Substance of Interview including description of the general nature of what was agreed to if an agreement was reached, or any other comments: \_\_\_\_\_`. (A fuller description, if necessary, and a copy of the amendments which the examiner agreed would render the claims allowable, if available, must be attached. Also, where no copy of the amendments that would render the claims allowable is available, a summary thereof must be attached.) THE FORMAL WRITTEN REPLY TO THE LAST OFFICE ACTION MUST INCLUDE THE SUBSTANCE OF THE INTERVIEW. (See MPEP Section 713.04). If a reply to the last Office action has already been filed, APPLICANT IS GIVEN ONE MONTH FROM THIS INTERVIEW DATE TO FILE A STATEMENT OF THE SUBSTANCE OF THE INTERVIEW. See Summary of Record of Interview requirements on reverse side or on attached sheet. Applicants will consider specifying the surface tension of the disclosed surfactants in the Yn reference to aid search process; amend claims to limit specific surfactants; and limit the specific surfactants to a specific genus. Pendingobinousness rejectings rejection will be reconsidered upon applicant's of showing of further distinction between the prior and applicants's invention with surfactants having dynamical tension of 57 mN/m or ceas. Regarding the daim objections to claims 6.71 and 18. applicants will consider deleting the process step limitations and adding limitations on particle size to define the structure of the claimed composition. Examiner Note: You must sign this form unless it is an Attachment to a signed Office action.